

40V P-Channel Mosfet

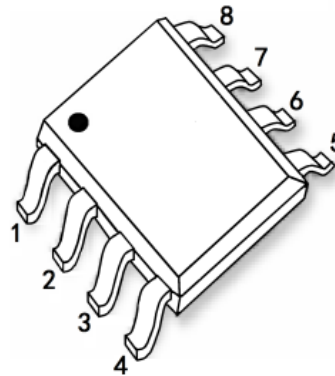
FEATURES

- $R_{DS(ON)}=20m\Omega(Typ.) @V_{GS}=20V, I_D=7.5A$

APPLICATIONS

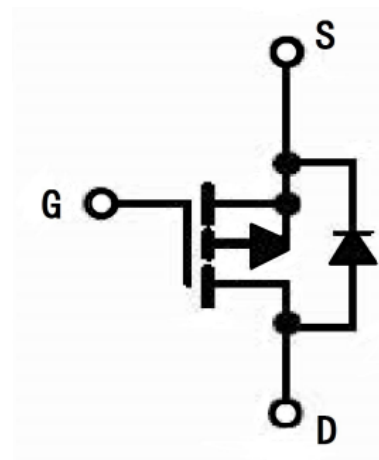
- Battery switching application
- Hard switched and high frequency circuits
- Power management

SOP-8



JST08P40S8

P-CHANNEL MOSFET



MAXIMUM RATINGS TC=25°C unless otherwise specified

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-Source Voltage	-40	V
I_D	Continuous Drain Current	-7.5	A
I_{DM}	Pulsed Drain Current	-24	A
V_{GSS}	Gate-Source Voltage	± 20	V
P_D	Power Dissipation	3	W
T_J, T_{STG}	Operating Junction and Storage Temperature Range	150 , -55 to 150	°C
T_L	Maximum Temperature for Soldering	300	°C

ELECTRICAL CHARACTERISTICS $T_c = 25^\circ\text{C}$ unless otherwise specified :

OFF Characteristics						
Symbol	Param	Test Condition	Rating			Units
			Min.	Typ.	Max.	
V _{DSS}	Drain to Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-40	--	--	V
I _{DSS}	Drain to Source Leakage Current	V _{DS} = -40V, V _{GS} = 0V	--	--	-1	μA
I _{GSS(F)}	Gate to Source Forward Leakage	V _{GS} =+20V	--	--	100	nA
I _{GSS(R)}	Gate to Source Reverse Leakage	V _{GS} =-20V	--	--	-100	nA
ON Characteristics						
Symbol	Param	Test Condition	Rating			Units
			Min.	Typ.	Max.	
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} =-10V, I _D =-5A	--	20	28	mΩ
R _{DS(ON)}	Drain-to-Source On-Resistance	V _{GS} =-4.5V, I _D =-5A	--	26	40	mΩ
V _{GS(TH)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = -250μA	-1.2	-1.65	-2.3	V
Dynamic Characteristics						
Symbol	Param	Test Condition	Rating			Units
			Min.	Typ.	Max.	
g _{fs}	Forward Transconductance	V _{DS} =-5V, I _D =-5A	20	--	--	S
C _{iss}	Input Capacitance	V _{GS} = 0V	--	1450	--	pF
C _{oss}	Output Capacitance	V _{DS} = -20V	--	180	--	pF
C _{rss}	Reverse Transfer Capacitance	f = 1.0MHz	--	150	--	pF
Resistive Switching Characteristics						
Symbol	Param	Test Condition	Rating			Units
			Min.	Typ.	Max.	
t _{d(ON)}	Turn-on Delay Time	I _D =-5A	--	8	--	ns
t _r	Rise Time	V _{DS} = -20V	--	7	--	
t _{d(OFF)}	Turn-Off Delay Time	V _{GS} = 10V	--	25	--	
t _f	Fall Time	R _G = 3.0Ω	--	9	--	
Q _g	Total Gate Charge	I _D =-5A	--	24	--	nC
Q _{gs}	Gate to Source Charge	V _{DS} = -20V	--	3.5	--	
Q _{gd}	Gate to Drain (“Miller”) Charge	V _{GS} = -10V	--	6	--	
Source-Drain Diode Characteristics						
Symbol	Param	Test Condition	Rating			Units
			Min.	Typ.	Max.	
I _S	Diode Forward Current		--	--	-7.5	A
V _{SD}	Diode Forward Voltage	I _S =-6A, V _{GS} =0V	--	--	-1.2	V
Symbol	Param	Typ.			Units	
R _{θ JA}	Junction-to-Ambient	50			°C/W	

TYPICAL PERFORMANCE CHARACTERISTICS

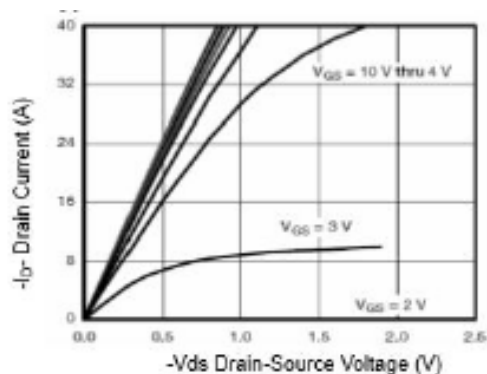


Figure 1 Output Characteristics

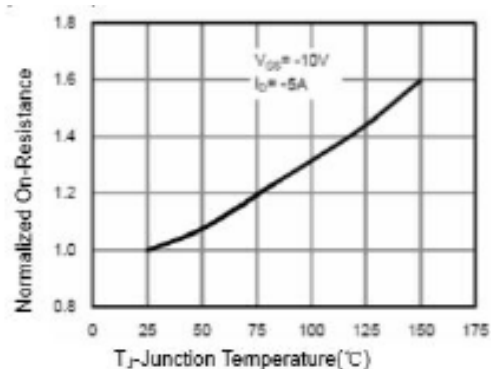


Figure 4 $R_{DS(on)}$ -Junction Temperature

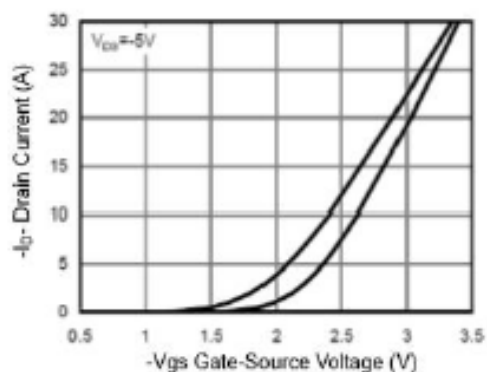


Figure 2 Transfer Characteristics

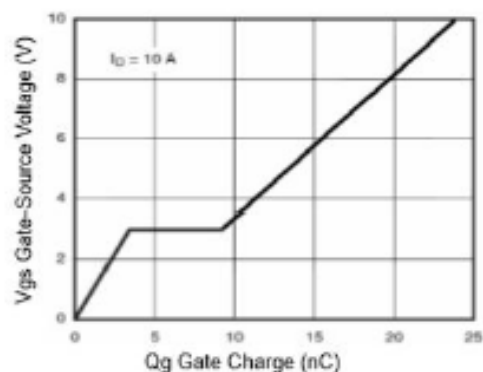


Figure 5 Gate Charge

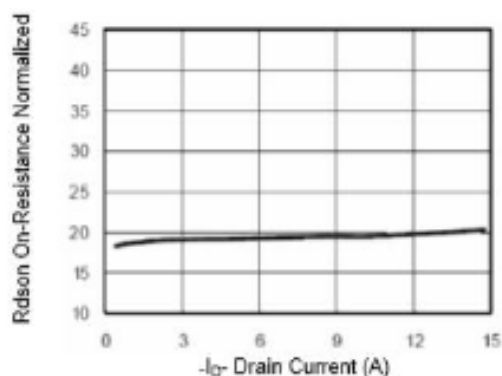


Figure 3 $R_{DS(on)}$ -Drain Current

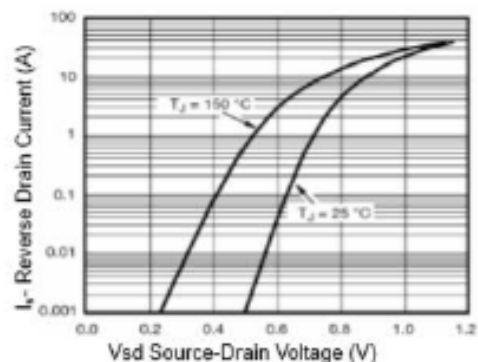


Figure 6 Source-Drain Diode Forward

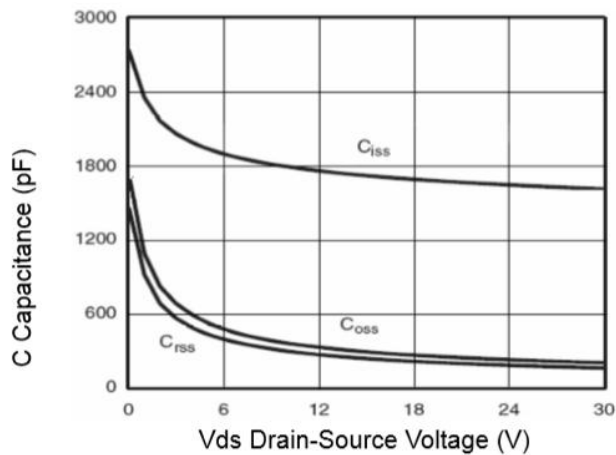


Figure 7 Capacitance vs V_{ds}

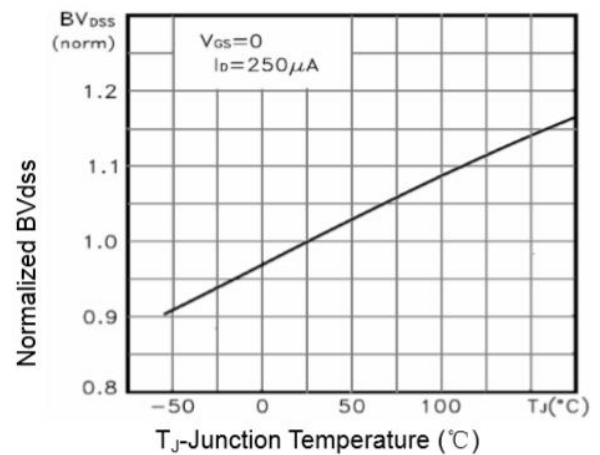


Figure 9 BV_{dss} vs Junction Temperature

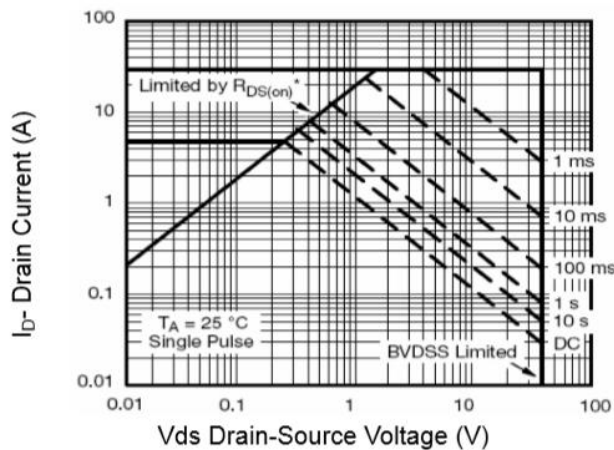


Figure 8 Safe Operation Area

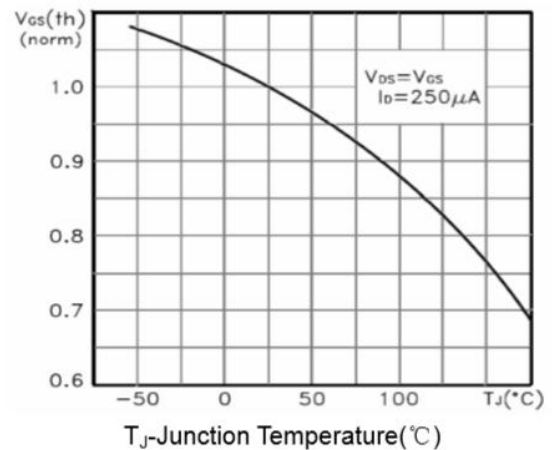


Figure 10 $V_{GS(th)}$ vs Junction Temperature

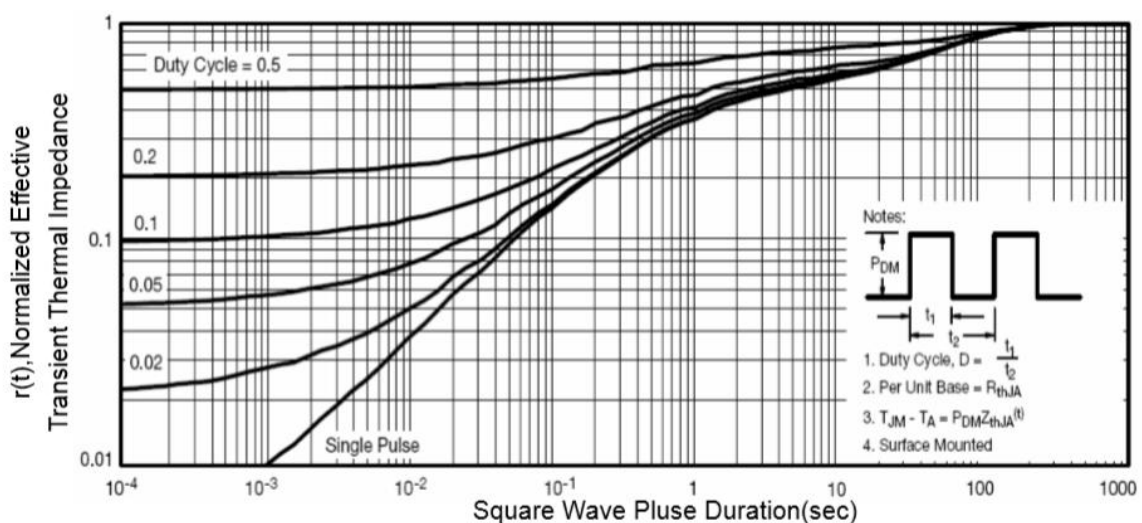
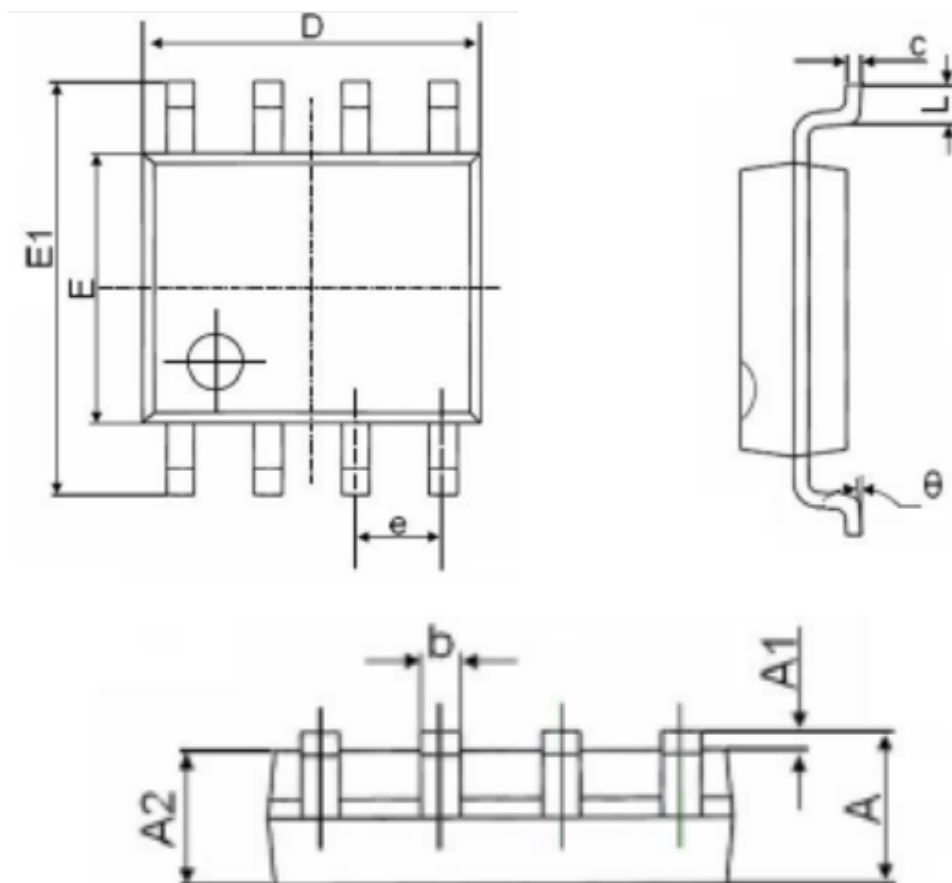


Figure 11 Normalized Maximum Transient Thermal Impedance

SOP-8 PACKAGE OUTLINE DRAWING



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.063	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.063	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.27(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°